## WHAT IS CLAIMED IS:

- 1 1. A light emitting diode, comprising:
- 2 a semiconductor substrate;
- 3 a light-emitting region including an active layer provided
- 4 between a first conductivity type cladding layer formed on the
- 5 semiconductor substrate and a second conductivity type cladding
- 6 layer;
- 7 a transparent conductive film made of a metal oxide and
- 8 located over the light-emitting region;
- **9** a first electrode formed on the upper side of the
- 10 transparent conductive film;
- a second electrode formed on the whole or a part of the
- 12 bottom of the semiconductor substrate; and
- a layer for preventing exfoliation of the transparent
- 14 conductive film, the preventing layer being made of a compound
- 15 semiconductor containing at least aluminum and located between
- 16 the light-emitting region and the transparent conductive film.
  - 1 2. The light emitting diode as defined in claim 1,
  - 2 wherein:
  - 3 the preventing layer contains a conductivity type
  - 4 determination impurity at a concentration of  $1 \times 10^{19}$  cm<sup>-3</sup> or
  - 5 higher.
  - 1 3. The light emitting diode as defined in claim 1,

- 2 wherein:
- 3 the preventing layer has a film thickness of 300 nm or less.
- 1 4. The light emitting diode as defined in claim 2,
- 2 wherein:
- 3 the preventing layer has a film thickness of 300 nm or less.
- 5. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the transparent conductive film is made of indium tin
- 4 oxide.
- 1 6. The light emitting diode as defined in claim 2,
- 2 wherein:
- 3 the transparent conductive film is made of indium tin
- 4 oxide.
- 7. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the preventing layer is made of an arsenic compound.
- 1 8. The light emitting diode as defined in claim 2,
- 2 wherein:
- 3 the preventing layer is made of an arsenic compound.
- 9. The light emitting diode as defined in claim 1,

- 2 wherein:
- 3 the light-emitting region is made of  $(Al_xGa_{1-x})_yIn_{1-y}P$  (0  $\leq$
- 4  $X \le 1, 0 \le Y \le 1$ ).
- 1 10. The light emitting diode as defined in claim 2,
- 2 wherein:
- 3 the light-emitting region is made of  $(Al_xGa_{1-x})_yIn_{1-y}P$  (0 \le 1
- 4  $X \le 1, 0 \le Y \le 1$ ).
- 1 11. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the preventing layer is an AlGaAs layer having a bandgap
- 4 which is smaller than that of the active layer; and
- 5 the AlGaAs layer is made of  $Al_xGa_{1-x}As$  (0.01  $\leq X \leq$  0.43).
- 1 12. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the AlGaAs layer has a carrier concentration of  $1 \times 10^{19}$
- $\mathbf{4}$  cm<sup>-3</sup> or higher.
- 1 13. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the AlGaAs layer has a carrier concentration of  $1 \times 10^{19}$
- 4  $cm^{-3}$  or higher.
- 1 14. The light emitting diode as defined in claim 1,

- 2 wherein:
- 3 the AlGaAs layer is added with at least one of Zn, Be, and
- 4 Mg.
- 1 15. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the AlGaAs layer is added with at least one of Zn, Be, and
- **4** Mg.
- 1 16. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the AlGaAs layer is added with at least one of Zn, Be and
- 4 Mg, and C; and
- 5 C is autodoped.
- 1 17. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the AlGaAs layer is added with at least one of Zn, Be and
- 4 Mg, and C; and
- 5 C is autodoped.
- 1 18. The light emitting diode as defined in claim 1,
- 2 wherein:
- the AlGaAs layer is formed at a growth temperature of 600°C
- 4 or lower.

- 1 19. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the AlGaAs layer is formed at a growth temperature of 600°C
- 4 or lower.
- 1 20. The light emitting diode as defined in claim 1,
- 2 wherein:
- 3 the AlGaAs layer is formed at a V/III ratio in raw materials
- 4 of 50 or less at the time of growth.
- 1 21. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the AlGaAs layer is formed at a V/III ratio in raw materials
- 4 of 50 or less at the time of growth.
- 1 22. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the transparent conductive film is made of indium tin
- 4 oxide.
- 1 23. The light emitting diode as defined in claim 11,
- 2 wherein:
- 3 the light-emitting region is made of  $(Al_xGa_{1-x})_yIn_{1-y}P$  (0 \le 1
- 4  $X \le 1, 0 \le Y \le 1$ ).